

Notice of References Cited

Application/Control No.

10/721,247

Applicant(s)/Patent Under
Reexamination
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Examiner

JASON HECKERT

Art Unit

1792

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hall Effect Sensor: Retrieved from " http://hades.mech.northwestern.edu/wiki/index.php/Hall_Effect_Sensor "
	V	
	W	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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